

MOSFET - N-Channel, Shielded Gate POWERTRENCH®

40 V, 80 A, 2.1 mΩ

FDMC8360L

General Description

This N-Channel MOSFET is produced using **onsemi's** advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Features

- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 2.1 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 27 \text{ A}$
- Max $R_{DS(on)} = 3.1 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 22 \text{ A}$
- High Performance Technology for Extremely Low R_{DS(on)}
- Termination is Lead-Free
- 100% UIL Tested
- This Device is Pb-Free, Halide Free and is RoHS Compliant

Application

• DC-DC Conversion

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

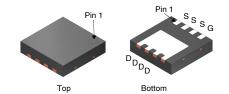
Symbol	Parameter	Ratings	Units
VDS	Drain to Source Voltage	40	٧
Vgs	Gate to Source Voltage	±20	٧
I _D	$ \begin{array}{ccc} \text{Drain Current} & & & & \\ -\text{Continuous} & & & & \\ -\text{Continuous} & & & & \\ -\text{Continuous} & & & & \\ -\text{Pulsed} & & & & & \\ \end{array} $	80 27 240	Α
Eas	Single Pulse Avalanche Energy (Note 3)	294	mJ
P _D	Power Dissipation $T_C = 25^{\circ}C$	54	W
	Power Dissipation $T_A = 25^{\circ}C$ (Note 1a)	2.3	
ТЈ, Тѕтс	Operating and Storage Junction Temperature Range	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
Rejc	Thermal Resistance, Junction-to-Case (Note 1)	2.3	°C/W
R _θ JA	Thermal Resistance, Junction-to-Ambient (Note 1a)	53	°C/W

V _{DS}	R _{DS(ON)} MAX	I _D MAX
40 V	2.1 mΩ @ 10 V	80 A
	3.1 mΩ @ 4.5 V	



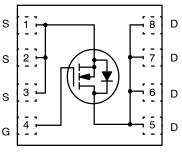
WDFN8 3.3x3.3, 0.65P CASE 483AW

MARKING DIAGRAM

FDMC 8360L ALYW

FDMC8360L = Specific Device Code
A = Assembly Site
L = Wafer Lot Number
YW = Assembly Start Week

PIN ASSIGNMENT



N-Channel MOSFET

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMC8360L	WDFN8 (Pb-Free, Halide Free)	3000 / Tape & Reel

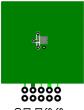
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS			•		•
ΔBV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	_	_	V
$\frac{\Delta BV_{DSS}}{\Delta T}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	22	-	mV/°C
$\Delta T_{ m J}$ $I_{ m DSS}$	Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V	_	_	1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	пA
ON CHARAC		- 43 1, - 133		<u> </u>		1
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C	_	-6	-	mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 27 A	_	1.6	2.1	mΩ
23(011)		V _{GS} = 4.5 V, I _D = 22 A	_	2.3	3.1	1
		V _{GS} = 10 V, I _D = 27 A, T _J = 125°C	_	2.2	2.9	1
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 27 A	_	138	_	S
OYNAMIC CH	HARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	_	4140	5795	pF
C _{oss}	Output Capacitance		-	1230	1725	pF
C _{rss}	Reverse Transfer Capacitance		-	36	60	pF
R _g	Gate Resistance		0.1	0.9	2.7	Ω
SWITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 20 \text{ V}, I_D = 27 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	-	15	28	ns
t _r	Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	-	6.7	14	ns
t _{d(off)}	Turn-Off Delay Time	7	-	38	60	ns
t _f	Fall Time	1	_	5.3	11	ns
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V V _{DD} = 20 V	-	57	80	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $I_D = 27 \text{ A}$	_	26	37	nC
Qgs	Gate to Source Charge		_	11	-	nC
Qgd	Gate to Drain "Miller" Charge	7	-	5.7	-	nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS					
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 27 A (Note 2)	-	0.8	1.3	V
		V _{GS} = 0 V, I _S = 1.9 A (Note 2)	_	0.7	1.2	1
t _{rr}	Reverse Recovery Time	I _F = 27 A, di/dt = 100 A/μs	-	49	80	ns
Q _{rr}	Reverse Recovery Charge	1	_	29	46	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in 2 pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0 %. 3. E_{AS} of 294 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 14 A, V_{DD} = 40 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 44 A. 4. Pulsed Id limited by junction temperature, td <= 100 μ S, please refer to SOA curve for more details.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

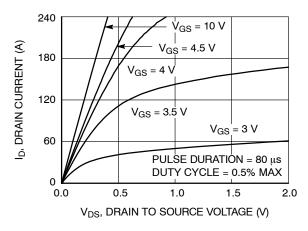


Figure 1. On-Region Characteristics

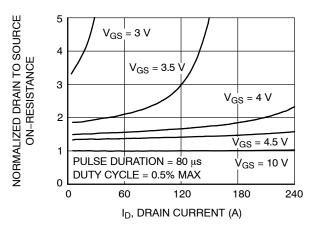


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

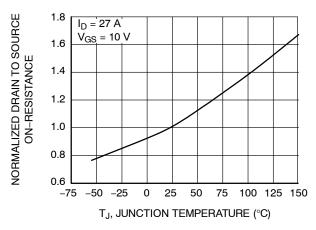


Figure 3. Normalized On Resistance vs. Junction Temperature

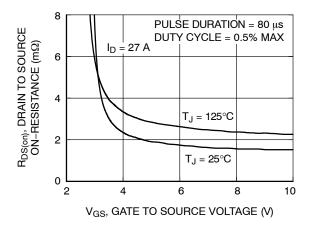


Figure 4. On-Resistance vs. Gate to Source Voltage

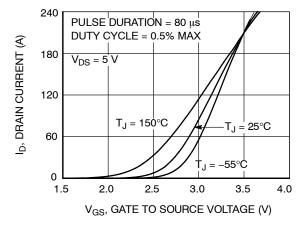


Figure 5. Transfer Characteristics

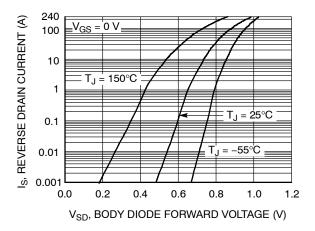


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

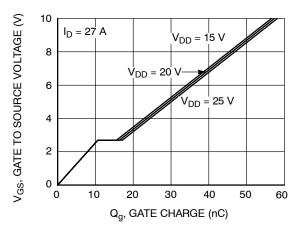


Figure 7. Gate Charge Characteristics

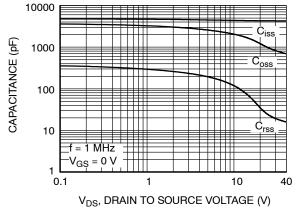


Figure 8. Capacitance vs. Drain to Source Voltage

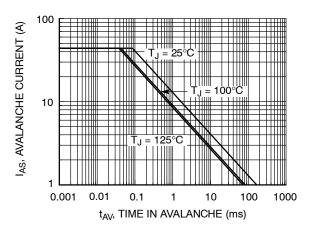


Figure 9. Unclamped Inductive Switching Capability

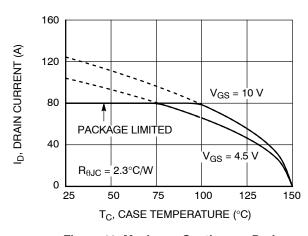


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

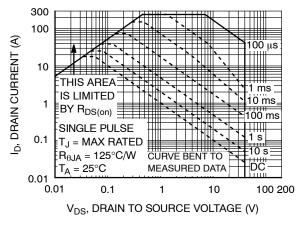


Figure 11. Forward Bias Safe Operating Area

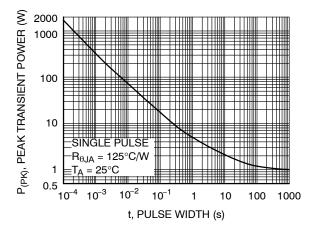


Figure 12. Single Pulse Maximum Power Dissipation

$\textbf{TYPICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted}) \ (continued)$

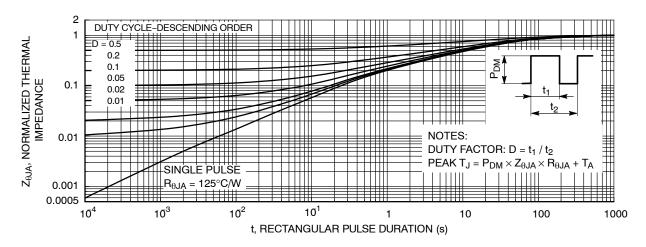


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

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TERMINAL #1

INDEX AREA

(D/2 X E/2)

⊃ aaa C

WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

DATE 22 MAR 2024

NOTES:

С

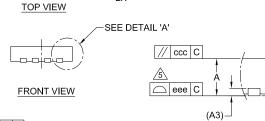
SEATING

PLANE

<u></u>

DETAIL A

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- ©COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



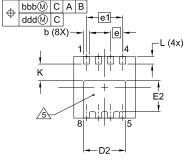
2X

aaa C

Α

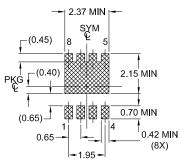
5

В



BOTTOM VIEW

LAND PATTERN RECOMMENDATION



*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

MILLIMETERS DIM MIN NOM MAX 0.70 0.75 Α 0.80 Α1 0.05 А3 0.20 REF b 0.27 0.32 0.37 D 3.30 BSC D2 2.17 2.27 2.37 Ε 3.30 BSC E2 1.56 1.66 1.76 е 0.65 BSC 1.95 BSC e1 Κ 0.90 L 0.30 0.40 0.50 0.10 aaa bbb 0.10 0.10 CCC ddd 0.05 0.05 eee

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN8 3.30x3.30x0.75, 0.65P		PAGE 1 OF 1	

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